

HAC RF Test Report

For

Applicant Name: Xwireless LLC

Address: 11565 Old Georgetown Road, Rockville, MD, USA

EUT Name: Mobile Phone

Model Number: HD65

Issued By

Company Name: BTF Testing Lab (Shenzhen) Co., Ltd.

F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park,

Address: Tantou Community, Songgang Street, Bao'an District, Shenzhen,

China

Report Number: BTF230413R01401

Test Standards: ANSI C63.19-2011 FCC 47 CFR §20.19 KDB 285076 D01v06

KDB 285076 D02v04 KDB 285076 D03v01r05

FCC ID: 2ADLJ-HD65

Test Conclusion: Pass

Test Date: 2023-05-10 to 2023-05-12

Date of Issue: 2023-05-15

Prepared By: Monica Zhou

Monica Zhou / Project Engineel

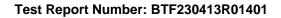
Date: 2023-05-15

Approved By:

Ryan.CJ / EMC Manager

Date: 2023-05-15

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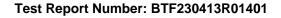


Revision History					
Version	Issue Date Revisions Content				
R_V0	2023-05-15	Original			
Note:	Once the revision has	Once the revision has been made, then previous versions reports are invalid.			



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1. Introduction

1.1 Identification of Testing Laboratory

Company Name:	BTF Testing Lab (Shenzhen) Co., Ltd.		
Address: F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, 7 Community, Songgang Street, Bao'an District, Shenzhen, China			
Phone Number: +86-0755-23146130			
Fax Number:	+86-0755-23146130		

1.2 Identification of the Responsible Testing Location

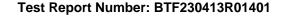
Test Location:	BTF Testing Lab (Shenzhen) Co., Ltd.		
Address:	F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China		
Description:	All measurement facilities used to collect the measurement data are located at F101,201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China		
FCC Registration Number	518915		
Designation Number	CN1330		

1.3 Laboratory Condition

Ambient Temperature:	21℃ to 25℃	
Ambient Relative Humidity:	48% to 59%	
Ambient Pressure:	100 kPa to 102 kPa	

1.4 Announcement

- (1) The test report reference to the report template version v0.
- (2) The test report is invalid if not marked with the signatures of the persons responsible for preparing, reviewing and approving the test report.
- (3) The test report is invalid if there is any evidence and/or falsification.
- (4) This document may not be altered or revised in any way unless done so by BTF and all revisions are duly noted in the revisions section.
- (5) Content of the test report, in part or in full, cannot be used for publicity and/or promotional purposes without prior written approval from the laboratory.
- (6) The laboratory is only responsible for the data released by the laboratory, except for the part provided by the applicant.





2. Product Information

2.1 Application Information

Company Name:	Xwireless LLC	
Address:	11565 Old Georgetown Road, Rockville, MD, USA	

2.2 Manufacturer Information

Company Name:	Xwireless LLC
Address:	11565 Old Georgetown Road, Rockville, MD, USA

2.3 Factory Information

Company Name: ZTECH COMMNICATION(SZ) CO LTD	
Address:	FL 7 BLOCK D BAO'AN ZHIGU INNOVATION PARK YIN'TIAN ROAD NO.4
Address.	XI'XIANG STR' BAO'AN DISTRICT SZ CHINA

2.4 General Description of Equipment under Test (EUT)

EUT Name	Mobile Phone	
Under Test Model Name	HD65	
Sample No.	BTFSN230413E008-1/1	

2.5 Equipment under Test Ancillary Equipment

	Rechargeable Battery		
Ancillary Equipment 1	Capacity	4000mAh	
	Rated Voltage	4.45V	

2.6 Technical Information

	2G Network GSM/GPRS 850/1900		
	3G Network WCDMA/HSDPA/HSUPA Band 2/4/5		
Network and Wireless	4G Network FDD LTE Band 2/4/5/12/13/25/26/66/71 TDD LTE Band 41		
connectivity	2.4G WIFI 802.11b, 802.11g, 802.11n(HT20/HT40)		
•	5G WIFI 802.11a, 802.11n(HT20/HT40), 802.11ac(VHT20/VHT40/VHT80)		
	BT (EDR+BLE)		





2.7 Air Interfaces / Bands Indicating Operating Modes

Air Interface	Band	Туре	Simultaneous Transmitter	Name of Service
	850	VO	WLAN & BT	CMRS Voice
GSM	1900	VO	WLAN & BT	CMRS Voice
	GPRS/EGPRS	DT	N/A	N/A
	Band II	VO	WLAN & BT	CMRS Voice
WCDMA	Band IV	VO	WLAN & BT	CMRS Voice
WCDMA	Band V	VO	WLAN & BT	CMRS Voice
	HSPA	DT	N/A	N/A
	Band 2	VD	WLAN & BT	VoLTE
	Band 4	VD	WLAN & BT	VoLTE
	Band 5	VD	WLAN & BT	VoLTE
	Band 12	VD	WLAN & BT	VoLTE
LTE	Band 13	VD	WLAN & BT	VoLTE
LIE	Band 25	VD	WLAN & BT	VoLTE
	Band 26	VD	WLAN & BT	VoLTE
	Band 41	VD	WLAN & BT	VoLTE
	Band 66	VD	WLAN & BT	VoLTE
	Band 71	VD	WLAN & BT	VoLTE
WLAN	2.4g & 5g	DT	WWAN	N/A
ВТ	2450	DT	WWAN	N/A

⁺ HAC Rating was not based on concurrent voice and data modes; Noncurrent mode was found to represent worst case rating for both M and T rating.

Note1: The air interface is exempted from testing by low power exemption that its average antenna input power plus its MIF is ≤17 dBm, and is rated as M4.

Note2: According to ANSI C63.19 2011-version, for the air interface technology of a device is exempt from testing whose peak antenna input power, averaged over intervals ≤50 μs, is ≤23 dBm. An RF air interface technology that is exempted from testing shall be rated as M4.

3. Summary of Test Results

3.1 Test Standards

No.	Identity	Document Title
1	ANSI C63.19-2011	American National Standard for Methods of Measurement of Compatibility between Wireless Communication Devices and Hearing Aids
2	FCC 47 CFR §20.19	Hearing Aid Compatible Mobile Headsets
3	KDB 285076 D01v06	Equipment Authorization Guidance for Hearing Aid Compatibility
4	KDB 285076 D02v04	Guidance for performing T-Coil tests for air interfaces supporting voice over IP (e.g., LTE and WiFi) to support CMRS based telephone services
5	KDB 285076 D03v01r05	Hearing aid compatibility frequently asked questions

NA: Not Applicable
VO: Voice Only
VD: GMRS and IP Voice Service over Digital Transport
DT: Digital Transport Only



3.2 ANSI C63.19 HAC RF Categories

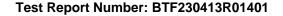
The ANSI Standard presents performance requirements for acceptable interoperability of hearing with wireless communications devices. When these parameters are met, a hearing aid operates acceptably in close proximity to a wireless communications device.

WD RF audio Interference level categories in logarithmic units

Emission categories	<960MHz Limits for E-field emissions	>960MHz Limits for E-field emissions
M1	50 to 55 dB (V/m)	40 to 45 dB (V/m)
M2	45 to 50 dB (V/m)	35 to 40 dB (V/m)
M3	40 to 45 dB (V/m)	30 to 35 dB (V/m)
M4	< 40 dB (V/m)	< 30 dB (V/m)

3.3 Summary of HAC M-Rating

Band	Channel	Measurement Result		M-Rating		
	Low (128)	E-Field dB (V/m)	33.53	M4		
GSM850	Middle(190)	E-Field dB (V/m)	34.30	M4		
	High(251)	E-Field dB (V/m)	33.69	M4		
	Low (512)	E-Field dB (V/m)	27.11	M4		
GSM1900	Middle(661)	E-Field dB (V/m)	26.69	M4		
	High(810)	E-Field dB (V/m)	26.71	M4		
HAC Rate Category: M4						





3.4 HAC Test Uncertainty

The following measurement uncertainty levels have been estimated for tests performed on the EUT as specified in ANSI C6 3.19: 2011. This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level usin g a coverage factor of k=2.

UNCERTAINTY EVALUATION FOR RF HAC MEASUREMENT								
Uncertainty Component	Tol (±dB)	Prob. Dist.	Div.	Uncertainty (dB)	Uncertainty (%)			
Measurement System								
RF reflections	0.1	R	√3	0.06				
Field probe conv. Factor	0.4	R	√3	0.23				
Field probe anisotropy	0.25	R	√3	0.14				
Positioning accuracy	0.2	R	√3	0.12				
Probe cable placement	0.1	R	√3	0.06				
System repeatability	0.2	R	√3	0.12				
EUT repeatability	0.4	N	1	0.40				
Combined Standard Uncertainty		N	1	0.52				
Expanded Uncertainty (95% CONFIDENCE INTERVAL)		N	K=2	1.03	12.65			
REPORTED Expanded uncertainty (confidence level of 95%, k = 2)		N	K=2	1.00	13.00			



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4. Measurement System

4.1 Definition of Hearing Aid Compatibility (HAC)

The purpose of this standard is to establish categories for hearing aids and for WD (wireless communications devices) that can indicate to health care practitioners and hearing aid users which hearing aids are compatible with which WD, and to provide tests that can be used to assess the electromagnetic characteristics of hearing aids and WD and assign them to these categories. The various parameters required, in order to demonstrate compatibility and accessibility are measured. The design of the standard is such that when a hearing aid and WD achieve one of the categories specified, as measured by the methodology of this standard, the indicated performance is realized.

In order to provide for the usability of a hearing aid with a WD, several factors must be coordinated:

- a) Radio frequency (RF) measurements of the near-field electric and magnetic fields emitted by a WD to categorize these emissions for correlation with the RF immunity of a hearing aid.
- b) Magnetic field measurements of a WD emitted via the audio transducer associated with the T-coil mode of the hearing aid, for assessment of hearing aid performance.
- c) Measurements with the hearing aid and a simulation of the categorized WD T-coil emissions to assess the hearing aid RF immunity in the T-coil mode.

The WD radio frequency (RF) and audio band emissions are measured.

Hence, the following are measurements made for the WD:

- a) RF E-Field emissions
- b) T-coil mode, magnetic signal strength in the audio band
- c) T-coil mode, magnetic signal and noise articulation index
- d) T-coil mode, magnetic signal frequency response through the audio band

Corresponding to the WD measurements, the hearing aid is measured for:

- a) RF immunity in microphone mode
- b) RF immunity in T-coil mode



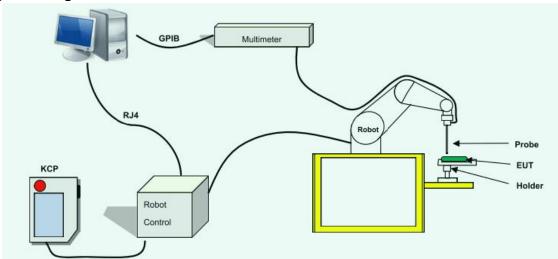


4.2 HAC RF Test Configuration and Setting

For HAC RF emission testing, the EUT was linked and controlled by wireless communication test set. Communication between the EUT and the wireless communication test set was established by air link. The distance between the EUT and the communicating antenna of the test set is larger than 50 cm and the output power radiated from the wireless communication test set antenna is at least 30 dB smaller than the output power of EUT. The EUT was set from the wireless communication test set to radiate maximum output power during HAC testing.

4.3 MVG HAC System

MVG HAC System Diagram







4.3.1 Robot



A standard high precision 6-axis robot (Denso) with t eaches pendant with Scanning System

- · It must be able to scan all the volume of the phanto m to evaluate the tridimensional distribution of SAR.
- · Must be able to set the probe orthogonal of the surf ace of the phantom $(\pm 30^{\circ})$.
- Detects stresses on the probe and stop itself if nec essary to keep the integrity of the probe.

4.3.2 E-Field Probe



Figure 1 - MVG COMOHAC E field Probe

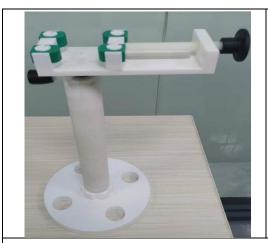
Probe Length	330 mm
Length of Individual Dipoles	3.3 mm
Maximum external diameter	8 mm
Probe Tip External Diameter	5 mm
Distance between dipoles / probe extremity	3 mm

Device Type	COMOHAC E FIELD PROBE
Manufacturer	MVG
Model	SCE
Serial Number	SN 07/22 EPH50
Product Condition (new / used)	New
Frequency Range of Probe	0.7GHz-2.5GHz
Resistance of Three Dipoles at Connector	Dipole 1: R1=0.208 MΩ
	Dipole 2: R2=0.220 MΩ
	Dipole 3: R3=0.212 MΩ



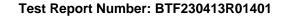


4.3.3 Device Holder/DUT positioner





During test, use DUT positioner adjust DUT to check if the Speaker is aligned with the positi oner center.



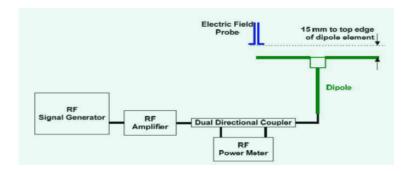


5. System Validation

According to ANSI C63.19, before hearing aid testing commences, the experimental setup shall be validated. Sub clauses 6.3.1through 6.3.5 include a set of pretest procedures designed to validate the experimental setup to ensure the accuracy of the results. To verify that the hearing aid performs per the manufacturer's specifications, 6.3.5 advises that the hearing aid be pretested per ANSI S3.22.

5.1 System Validation Setup

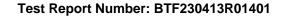
Using this setup configuration, the signal generator was adjusted for the desired output power 20dBm (100mW) at a specified frequency. The reference power from the coupled port of the directional coupler is recorded. Next, the output cable is connected to the reference dipole



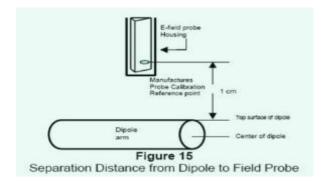
5.2 System Check Procedure

The input signal was an unmodulated continuous wave. The following points were taken into consideration in performing this check:

- Average Input Power P = 100mW RMS (20dBm RMS) after adjustment for return loss
- The test fixture must meet the 2 wavelength separation criterion
- The proper measurement of the 1 cm probe to dipole separation, which is measured from top surface of the dipole to the calibration reference point of the sensor, defined by the probe manufacturer is shown in the following diagram:



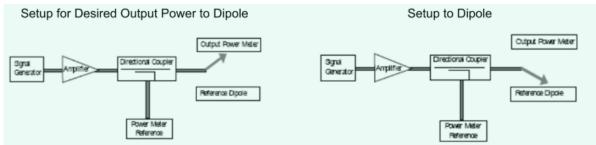


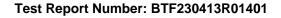


RF power was recorded using both an average reading meter and a peak reading meter. Readings of the probe are provided by the measurement system. To assure proper operation of the near-field measurement probe the input power to the dipole shall be commensurate with the full rated output power of the wireless device (e.g. – for a cellular phone wireless device the average peak antenna input power will be on the order of 100mW (i.e. - 20dBm) RMS after adjustment for any mismatch.

5.3 System Validation Procedure

A dipole antenna meeting the requirements given in C63.19 was placed in the position normally occupied by the WD. The le ngth of the dipole was scanned with both E-field and H-field probes and the maximum values for each—were recorded. Usi ng the near-field measurement system, scan the antenna over the radiating dipole and record the greatest field reading obs erved. Due to the nature of E-fields about free-space dipoles, the two E-field peaks measured over the dipole are averaged to compensate for non-paralellity of the setup see manufacturer method on dipole calibration certificates, Field strength mea surements shall be made only when the probe is stationary. RF power was recorded using both an average and a peak pow er reading meter.







6. Modulation Interference Factor (MIF)

The HAC Standard ANSI C63.19-2011 defines a new scaling using the Modulation Interference Factor (MIF). For any specific fixed and repeatable modulated signal, a modulation interference factor (MIF, expressed in dB) may be devel oped that relates its interference potential to its steady-state rms signal level or average power level. This factor is a function only of the audio-frequency amplitude modulation characteristics of the signal and is the same for field-strength and conducted power measurements. It is important to emphasize that the MIF is valid only for a specific repeatable audio-frequency amplitude modulation characteristic. Any change in modulation characteristic requires determination and application of a new MIF.

The MIF may be determined using a radiated RF field, a conducted RF signal, or in a preliminary stage, a mathematical analysis of a modeled RF signal:

- a) Verify the slope accuracy and dynamic range capability over the desired operating frequency band of a fast probe or sensor, square-law detector, as specified in D.3, and weighting system as specified in D.4 and D.5. For the probe and instrumentation included in the measurement of MIF, additional calibration and application of calibration factors are not required.
- b) Using RF illumination or conducted coupling, apply the specific modulated signal in question to the measurement system at a level within its confirmed operating dynamic range.
- c) Measure the steady-state rms level at the output of the fast probe or sensor.
- d) Measure the steady-state average level at the weighting output.
- e) Without changing the square-law detector or weighting system, and using RF illumination or conducted coupling, substitute for the specific modulated signal a 1kHz, 80% amplitude-modulated carrier at the same frequency and adjust its strength until the level at the weighting output equals the step d) measurement.
- f) Without changing the carrier level from step e), remove the 1 kHz modulation and again measure the steady-state rms level indicated at the output of the fast probe or sensor.
- g) The MIF for the specific modulation characteristic is provided by the ratio of the step f) measurement to the step c) measurement, expressed in dB ($20 \times \log(\text{step f})$)/step c)).

In practice, step e) and step f) need not be repeated for each MIF determination if the relationship between the two measurements has been preestablished for the measurement system over the operating frequency and dynamic ranges.

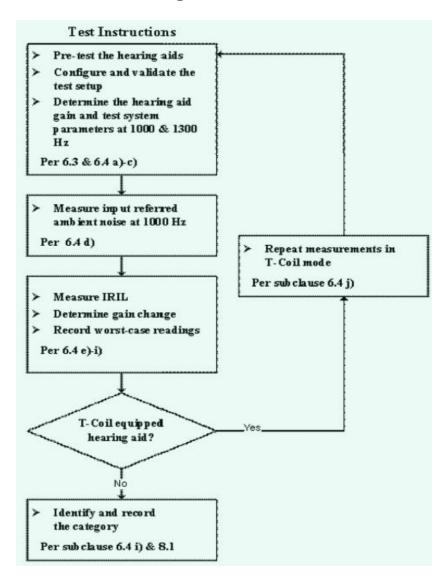
Modulation group	Modulation characteristics	MIF
CW	CW	-99.0
GSM	TDMA	3.3
WCDMA	UMTS-FDD	-27.2
LTE	LTE-FDD / RB=1 / BW=20 MHz / QPSK	-15.6

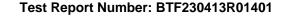
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7. HAC Immunity Measurement Procedures

7.1 HAC Measurement Process Diagram







7.2 HAC RF Test Setup

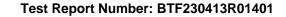


WD reference and plane for RF emission measurements

7.3 RF Emission Measurement Procedures

The following illustrate a typical RF emissions test scan over a wireless communications device:

- a. Proper operation of the field probe, probe measurement system, other instrumentation, and the positioning system was confirmed.
- b. WD is positioned in its intended test position, acoustic output point of the device perpendicular to the field probe.
- c. WD operation for maximum rated RF output power was configured and confirmed with the base station simulator, at the test channel and other normal operating parameters as intended for the test. The battery was ensured to be fully charged before each test.
- d. center sub-grid was centered over the center of the acoustic output (also audio band magnetic output, if applicable). The WD audio output was positioned tangent (as physically possible) to the measurement plane.
- e. urface calibration was performed before each setup change to ensure repeatable spacing and proper maintenance of the measurement plane using the HAC Phantom.
- f. measurement system measured the field strength at the reference location





8. Max. Conducted RF Output Power

2G

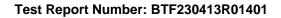
		Burst Average Power (dBm)			
GSM850	Maximum Tune-up (dBm)	CH128	CH190	CH251	
	(abiii)	824.2MHz	836.6MHz	848.8MHz	
GSM	32.00	31.65	31.85	31.80	
		Burst Average Power (dBm)			
GSM1900	Maximum Tune-up (dBm)	CH512	CH661	CH810	
		1850.2MHz	1880.0MHz	1909.8MHz	
GSM	30.50	30.20	29.86	29.43	

3G

		WCDMA Band II					
Mode	Maximum Tune-up	Conducted Power (dBm)					
Mode	(dBm)	CH9262	CH9400	CH9538			
		1852.4MHz	1880.0MHz	1907.6MHz			
RMC 12.2K	22.50	22.26	21.89	21.74			
			WCDMA Band IV				
Mode	Maximum Tune-up	Conducted Power (dBm)					
iviode	(dBm)	CH1312	CH1450	CH1513			
		1712.4MHz	1740.0MHz	1752.6MHz			
RMC 12.2K	23.00	22.42	22.50	22.41			
		WCDMA Band V					
Mode	Maximum Tune-up	Conducted Power (dBm)					
iviode	(dBm)	CH4132	CH4182	CH4233			
		826.4MHz	836.4MHz	846.6MHz			
RMC 12.2K	22.50	22.12	22.13	22.16			

4G

	LTE-FDD E	Band 2			Conducted Power(dBm)		
Daniel wielth	Madulatian	RB	DD -#+	Maximum Tune- up(dBm)	18700	18900	19100
Bandwidth	Modulation	allocation	RB offset	ир(иВііі)	1860.0MHz	1880.0MHz	1900.0MHz
			0	22.00	21.88	21.60	21.37
		1	50	22.50	22.32	21.91	21.74
			99	22.00	21.60	21.39	21.22
	QPSK		0	21.50	21.39	20.65	20.96
		50	25	21.50	21.11	20.79	20.68
			50	21.00	20.83	20.87	20.89
20MHz		100	0	21.50	21.15	20.78	20.91
ZUMHZ		1	0	21.50	21.19	20.79	20.97
			50	21.50	21.49	21.08	21.26
			99	21.00	20.92	20.66	20.83
	16QAM	50	0	20.50	20.47	19.66	20.02
			25	20.50	20.17	19.85	19.71
			50	20.00	19.87	19.89	19.89
		100	0	20.50	20.30	19.78	19.97

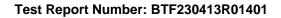




	LTE-FDD Ba	and 4			Conducted Power(dBm)		
December 2.10	March Jacks	RB	RB	Maximum Tune- up(dBm)	20050	20175	20300
Bandwidth	Modulation	allocation	offset	ир(иВііі)	1720.0MHz	1732.5MHz	1745.0MHz
			0	22.50	22.41	22.43	22.34
		1	50	23.00	22.87	22.84	22.78
			99	22.50	22.42	22.39	22.31
	QPSK	50	0	22.00	21.58	21.87	21.85
			25	22.00	21.75	21.78	21.72
			50	22.00	21.74	21.56	21.62
20MHz		100	0	22.00	21.66	21.69	21.73
ZUIVITZ		1	0	22.00	21.75	21.68	21.96
			50	22.50	22.17	22.07	22.37
			99	22.00	21.76	21.61	21.85
	16QAM		0	21.00	20.67	20.94	20.94
		50	25	21.00	20.83	20.80	20.79
			50	21.00	20.81	20.63	20.67
		100	0	21.00	20.75	20.75	20.82

	LTE-FDD Band 5				Conducted Power(dBm)		
De a decidab	NAs dedation	RB	RB	Maximum Tune- up(dBm)	20450	20525	20600
Bandwidth	Modulation	allocation	offset	αρ(αΔΙΙΙ)	829.0MHz	836.5MHz	844.0MHz
			0	22.50	21.98	22.08	21.98
		1	25	22.50	22.23	22.21	22.24
			49	22.50	22.04	21.94	21.87
	QPSK		0	21.50	21.11	21.27	21.03
		25	13	21.50	21.18	21.14	21.09
			25	21.50	21.15	21.05	20.84
400411-		50	0	21.50	21.15	21.13	20.94
10MHz			0	22.00	21.60	21.22	21.02
		1	25	22.00	21.81	21.43	21.25
			49	22.00	21.63	21.14	20.90
	16QAM		0	20.50	20.20	20.30	20.15
		25	13	20.50	20.28	20.19	20.22
			25	20.50	20.24	20.10	20.01
		50	0	20.50	20.19	20.15	19.95

	LTE-FDD Ban	ıd 12			Conducted Power(dBm)						
D	March Jacks	RB	RB	Maximum Tune- up(dBm)	23060	23095	23130				
Bandwidth	Modulation	allocation	offset	ир(иВт)	704.0MHz	707.5MHz	711.0MHz				
			0	22.00	21.82	21.90	21.99				
		1	25	22.50	22.10	22.19	22.20				
			49	22.50	21.93	21.97	22.05				
	QPSK		0	21.50	20.97	20.89	21.22				
		25	13	21.50	21.06	21.05	21.10				
			25	21.50	21.12	20.84	21.12				
400411-		50	0	21.50	21.06	20.80	21.18				
10MHz			0	21.50	21.44	21.10	20.96				
						1	25	22.00	21.74	21.35	21.21
				49	22.00	21.51	21.14	21.04			
	16QAM		0	20.50	20.09	19.94	20.36				
		25	13	20.50	20.17	20.12	20.20				
			25	20.50	20.22	19.86	20.24				
			50	0	20.50	20.10	19.92	20.26			

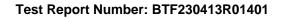




	LTE-FDD Band 13				Conducted Power(dBm)
David de la constitución de la c	Madulatian	RB	RB	Maximum Tune- up(dBm)	23230
Bandwidth	Modulation	allocation	offset	ир(ивпі)	782.0MHz
			0	23.00	22.62
		1	25	23.00	22.73
			49	22.50	22.44
	QPSK		0	22.00	21.81
		25	13	22.00	21.69
			25	22.00	21.61
10MHz		50	0	22.00	21.73
TUIVIEZ			0	22.50	22.03
		1	25	22.50	22.36
			49	22.00	21.99
	16QAM		0	21.00	20.92
		25	13	21.00	20.78
			25	21.00	20.73
		50	0	21.00	20.78

	LTE-FDD Ba	nd 25			Conducted Power(dBm)				
Dan decidab	NA advitation	RB	RB	Maximum Tune- up(dBm)	26140	26365	26590		
Bandwidth	Modulation	allocation	offset	ир(иВт)	1860.0MHz	1882.5MHz	1905.0MHz		
			0	22.00	21.99	21.72	21.53		
		1	50	22.50	22.33	22.10	21.92		
			99	22.00	21.72	21.62	21.41		
	QPSK		0	22.00	21.58	20.78	20.73		
		50	25	21.50	21.21	20.97	20.78		
					50	21.00	20.95	20.87	20.63
201411-		100	0	21.50	21.33	20.80	20.71		
20MHz			0	21.50	21.32	20.86	21.10		
	16QAM	1	50	22.00	21.66	21.27	21.37		
				99	21.50	21.01	20.87	21.04	
			0	21.00	20.56	19.81	19.79		
		50	25	20.50	20.32	20.01	19.81		
			50	20.00	19.99	19.99	19.67		
		100	0	20.50	20.41	19.87	19.79		

	LTE-FDD Ba	nd 26			Conducted Power(dBm)					
Dan decidab	Madulatian	RB	RB	Maximum Tune- up(dBm)	26765	26865	26965			
Bandwidth	Modulation	allocation	offset	up(usiii)	821.5MHz	831.5MHz	841.5MHz			
			0	22.50	21.99	22.12	22.07			
		1	38	22.50	22.23	22.36	22.16			
			74	22.50	22.11	22.01	21.94			
	QPSK		0	21.50	21.25	21.25	21.28			
		36	18	21.50	21.29	21.34	21.24			
			39	21.50	21.35	21.21	21.12			
458411-		75	0	21.50	21.26	21.24	21.19			
15MHz			0	22.00	21.64	21.36	21.56			
	I				1	38	22.00	21.90	21.48	21.53
			74	22.00	21.67	21.23	21.37			
	16QAM		0	20.50	20.23	20.33	20.26			
		36	18	20.50	20.35	20.39	20.20			
			39	20.50	20.36	20.27	20.15			
		75	0	20.50	20.30	20.27	20.22			

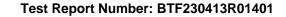




	LTE-TDD Ba	nd 41			Conducted Power(dBm)					
Daniel de la constante la const	Madulation	RB	RB	Maximum Tune- up(dBm)	39750	40620	41490			
Bandwidth	Modulation	allocation	offset	ир(иВііі)	2506.0MHz	2593.0MHz	2680.0MHz			
			0	24.00	22.61	23.62	23.78			
		1	50	24.00	22.72	23.90	23.71			
			99	24.00	22.63	23.93	23.36			
	QPSK	PSK	0	23.00	21.58	22.79	22.95			
		50	25	23.00	21.69	22.91	22.93			
						50	23.00	21.71	22.94	22.71
20MHz		100	0	23.00	21.62	22.86	22.77			
ZUIVIHZ			0	23.00	21.62	22.27	22.97			
				1	50	23.00	21.60	22.89	22.89	
					99	23.00	21.82	22.81	22.16	
	16QAM		0	22.00	20.55	21.75	21.85			
		50	25	22.00	20.65	21.94	21.80			
			50	22.00	20.66	21.85	21.65			
			100	0	22.00	20.61	21.84	21.73		

	LTE-FDD Ba	nd 66			Conducted Power(dBm)						
D 1 - 110	Marialada	RB	RB	Maximum Tune- up(dBm)	132072	132322	132572				
Bandwidth	Modulation	allocation	offset	ир(иВііі)	1720.0MHz	1745.0MHz	1770.0MHz				
			0	23.00	22.86	22.88	22.66				
		1	50	23.50	23.32	23.28	23.12				
			99	23.00	22.85	22.76	22.53				
	QPSK		0	22.50	22.06	22.32	21.87				
		50	25	22.50	22.20	22.19	21.98				
							50	22.50	22.25	22.04	22.02
001411		100	0	22.50	22.13	22.21	21.96				
20MHz			0	22.50	22.18	22.16	22.16				
	16QAM			1	50	23.00	22.64	22.50	22.50		
				99	22.50	22.23	21.99	22.09			
			0	21.50	21.10	21.39	20.89				
		50	25	21.50	21.25	21.25	20.92				
			50	21.50	21.32	21.10	20.99				
		100	0	21.50	21.16	21.27	20.98				

	LTE-FDD Ba	ınd 71			Conducted Power(dBm)					
6	Modulati	RB	RB	Maximum Tune- up(dBm)	133222	133322	133372			
Bandwidth	on	allocatio n	offset	ир(иВпт)	673.0MHz	683.0MHz	688.0MHz			
			0	22.00	21.68	21.48	21.53			
		1	50	22.50	22.16	21.81	21.96			
			99	22.00	21.75	21.65	21.87			
	QPSK		0	21.50	20.72	21.30	20.92			
		50	25	21.00	20.97	20.86	20.89			
					50	21.50	20.96	21.18	21.14	
20MHz		100	0	21.50	20.85	21.13	20.99			
ZUIVITZ	16QAM		0	21.00	20.39	20.37	20.56			
					1	50	21.50	20.87	20.91	21.01
				99	21.00	20.71	20.78	20.93		
			0	20.50	19.60	20.24	19.92			
		50	25	20.00	19.86	19.95	19.95			
			50	20.50	19.88	20.30	20.17			
		100	0	20.50	19.81	20.20	20.02			





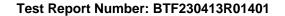
9. Low-Power Exemption

9.1 Tune-up Power

Mode	Tune-up Power (dBm)
GSM 850	32.00
GSM 1900	30.50
WCDMA II	22.50
WCDMA IV	23.00
WCDMA V	22.50
LTE Band 2	22.50
LTE Band 4	23.00
LTE Band 5	22.50
LTE Band 12	22.50
LTE Band 13	23.00
LTE Band 25	22.50
LTE Band 26	22.50
LTE Band 41	24.00
LTE Band 66	23.50
LTE Band 71	22.50

9.2 RF Emissions Lower Power Exemption

Mode	Tune-up Power (dBm)	MIF	Power + MIF(dB)	C63.19 Test Required?
GSM 850	32.00	3.3	35.3	Yes
GSM 1900	30.50	3.3	33.8	Yes
WCDMA II	22.50	-27.2	-4.7	No
WCDMA IV	23.00	-27.2	-4.2	No
WCDMA V	22.50	-27.2	-4.7	No
LTE Band 2	22.50	-15.6	6.9	No
LTE Band 4	23.00	-15.6	7.4	No
LTE Band 5	22.50	-15.6	6.9	No
LTE Band 12	22.50	-15.6	6.9	No
LTE Band 13	23.00	-15.6	7.4	No
LTE Band 25	22.50	-15.6	6.9	No
LTE Band 26	22.50	-15.6	6.9	No
LTE Band 41	24.00	-15.6	8.4	No
LTE Band 66	23.50	-15.6	7.9	No
LTE Band 71	22.50	-15.6	6.9	No





10. Test Equipment List

Description	Manufacturer	Model	Serial No./Version	Cal. Date	Cal. Due
PC	Dell	N/A	N/A	N/A	N/A
Test Software	MVG	N/A	OpenHAC V5.1.3	N/A	N/A
COMOHAC E-field Probe	MVG	SCE	07/22 EPH50	2023/02/06	2024/02/05
COMOHAC 800-950MHz reference dipole	MVG	SIDB835	07/22 DHA69	2023/02/06	2024/02/05
COMOHAC 1700-2000MHz reference dipole	MVG	SIDB1900	07/22 DHB70	2023/02/06	2024/02/05
6 1/2 Digital Multimeter	Keithley	DMM6500	4527164	2022/11/24	2023/11/23
MXG Vector Signal Generator	Agilent	N5182A	MY46240163	2022/11/24	2023/11/23
E-Series Avg. Power Sensor	KEYSIGHT	E9300A	MY55050017	2023/03/24	2024/03/23
EPM Series Power Meter	KEYSIGHT	E4418B	MY41293435	2023/03/24	2024/03/23
10DB Attenuator	MIDWEST MICROWAVE	263-10dB	/	2023/03/24	2024/03/23
Coupler	MERRIMAC	CWM-10R-10.8G	LOT-83391	2023/03/24	2024/03/23
Wideband Radio Communication Tester	ROHDE & SCHWARZ	CMW500	161997	2022/11/24	2023/11/23





ANNEX A HAC RF System Validation Result

			E-Field Scan			
Mode	Frequency (MHz)	Input Power (mW)	Measured Value (dBV/m)	Target Value (dBV/m)	Deviation (%)	Limit (%)
CW	835	100	215.88	210.0	-2.80	±25
CW	1900	100	146.86	146.1	-0.52	±25

System check at 835.00 MHz

Date of measurement: 10/5/2023

Experimental Conditions

Probe	SN_0722_EPH50			
Signal	CW			
Band	CW835			
Channels	middle			
Frequency (MHz)	835.00			

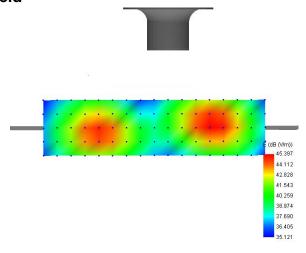
Results

E-field average [dB(V/m)]	215.88
Right E-field maximum [dB(V/m)]	215.56
Left E-field maximum [dB(V/m)]	216.51

Scan parameter

Scan area: length (mm), width (mm)	20.00, 80.00
Measurement point spacing (mm)	5
distance to reference plane (mm)	10.00
X and Y offset with the reference point (mm)	0.00, 0.00
Number of measurement points	85

RF audio interference near field







System check at 1900.00 MHz

Date of measurement: 10/5/2023

Experimental Conditions

Probe	SN_0722_EPH50	
Signal	CW	
Band	CW1900	
Channels	middle	
Frequency (MHz)	1900.00	

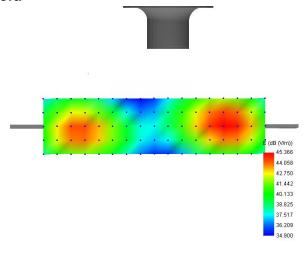
Results

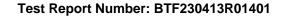
E-field average [dB(V/m)]	146.86
Right E-field maximum [dB(V/m)]	146.32
Left E-field maximum [dB(V/m)]	147.91

Scan parameter

Scan area: length (mm), width (mm)	20.00, 80.00
Measurement point spacing (mm)	5
distance to reference plane (mm)	10.00
X and Y offset with the reference point (mm)	0.00, 0.00
Number of measurement points	85

RF audio interference near field







ANNEX B HAC RF Measurement Result

Band	Channel	Frequency (MHz)	RF audio interference level [dB(V/m)]	Device compliant	Plot
	Low (128)	824.2MHz	33.53	Yes	/
GSM850	Middle(190)	836.6MHz	34.30	Yes	1#
	High(251)	848.8MHz	33.69	Yes	/
	Low (512)	1850.2MHz	27.11	Yes	2#
GSM1900	Middle(661)	1880.0MHz	26.69	Yes	/
	High(810)	1909.8MHz	26.71	Yes	/

Measurement at GSM850

Date of measurement: 10/5/2023

Experimental Conditions

Exportition and Conditions		
Probe	SN_0722_EPH50	
Signal	GSM	
Band	GSM850	
Channels	middle	
Channels Number	190	
Frequency (MHz)	836.60	
MIF	3.30	

Results

11000110	
Maximum value of RF audio interference field [dB(V/m)]	34.30
Category	M4
Measurement status	Complete

Grid visualisation

Legend:

- Blue cells are excluded

- Red cell contains the maximum RF audio interference level

Cell 1:	Cell 2:	Cell 3:
33.71	33.62	31.52
dB(V/m)	dB(V/m)	dB(V/m)
Cell 4:	Cell 5:	Cell 6:
33.98	34.30	32.22
dB(V/m)	dB(V/m)	dB(V/m)
Cell 7:	Cell 8:	Cell 9:
33.38	32.18	32.28
dB(V/m)	dB(V/m)	dB(V/m)

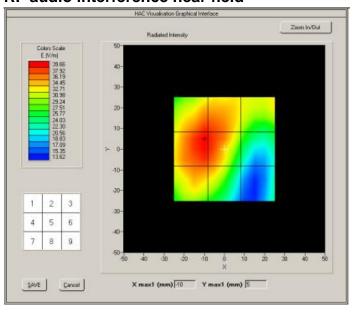




Scan parameter

Scan area: length (mm), width (mm)	50.00, 50.00
Measurement point spacing (mm)	5
distance to reference plane (mm)	15.00
X and Y offset with the reference point (mm)	0.00, 0.00
Number of measurement points	121

RF audio interference near field

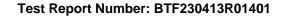


Measurement at GSM1900

Date of measurement: 10/5/2023

Experimental Conditions

Probe	SN_0722_EPH50	
Signal	GSM	
Band	GSM1900	
Channels	Low	
Channels Number	512	
Frequency (MHz)	1850.20	
MIF	3.30	





Results

Maximum value of RF audio interference field [dB(V/m)]	27.11
Category	M4
Measurement status	Complete

Grid visualisation

Legend:

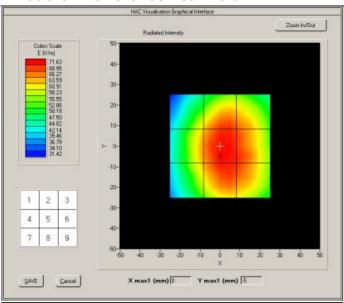
- Blue cells are excluded
- Red cell contains the maximum RF audio interference level

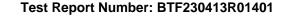
Cell 1:	Cell 2:	Cell 3:
25.84	26.85	26.39
dB(V/m)	dB(V/m)	dB(V/m)
Cell 4:	Cell 5:	Cell 6:
26.40	27.11	26.85
dB(V/m)	dB(V/m)	dB(V/m)
Cell 7:	Cell 8:	Cell 9:
26.18	27.04	26.81
dB(V/m)	dB(V/m)	dB(V/m)

Scan parameter

• • • • • • • • • • • • • • • • • • • •		
Scan area: length (mm), width (mm)	50.00, 50.00	
Measurement point spacing (mm)	5	
distance to reference plane (mm)	15.00	
X and Y offset with the reference point (mm)	0.00, 0.00	
Number of measurement points	121	

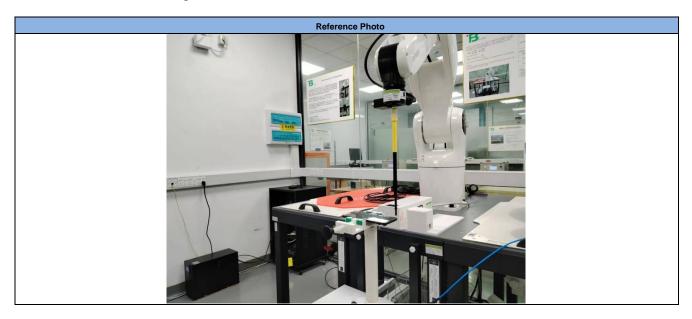
RF audio interference near field







ANNEX C Test Setup Photos



ANNEX D EUT External & Internal Photos

Please refer to RF Report.

ANNEX E Calibration Information

Please refer the document "Calibration.pdf".

Test Report Number: BTF230413R01401





BTF Testing Lab (Shenzhen) Co., Ltd.

F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China

www.btf-lab.com

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